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10-Ω QUAD SPDT ANALOG SWITCH

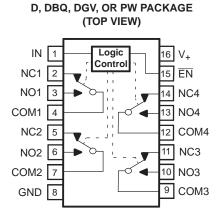
Check for Samples: TS3A5018

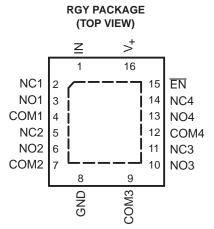
FEATURES

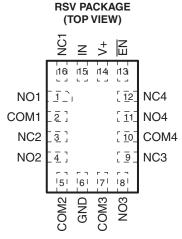
- Low ON-State Resistance (10 Ω)
- Low Charge Injection
- Excellent ON-State Resistance Matching
- Low Total Harmonic Distortion (THD)
- 2.3-V to 3.6-V Single-Supply Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)

APPLICATIONS

- Sample-and-Hold Circuits
- Battery-Powered Equipment
- Audio and Video Signal Routing
- Communication Circuits







DESCRIPTION/ORDERING INFORMATION

The TS3A5018 is a quad single-pole double-throw (SPDT) analog switch that is designed to operate from 2.3 V to 3.6 V. This device can handle both digital and analog signals, and signals up to V_{+} can be transmitted in either direction.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



ORDERING INFORMATION(1)

T _A	PACKAGE ⁽²)	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	SOIC - D	Tube of 40	TS3A5018D	TS3A5018	
	201C - D	Reel of 2500	TS3A5018DR	153A5016	
	SSOP (QSOP) – DBQ	Reel of 2500	TS3A5018DBQR	YA018	
	TSSOP – PW	Tube of 90	TS3A5018PW	YA018	
-40°C to 85°C	1350P - PW	Reel of 2000	TS3A5018PWR	TAUIO	
	TVSOP - DGV	Reel of 2000	TS3A5018DGVR	YA018	
	OFN – RGY	Reel of 3000	TS3A5018RGYR	2/4040	
	QFN - KG1	Reel of 3000	TS3A5018RGYRG4	YA018	
	uQFN – RSV	Reel of 3000	TS3A5018RSVR	ZUN	

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.
- (2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

SUMMARY OF CHARACTERISTICS(1)

Configuration	Quad Single-Pole, Double Throw (4 × SPDT)				
Number of channels	4				
ON-state resistance (r _{on})	7 Ω				
ON-state resistance match (Δr _{on})	0.3 Ω				
ON-state resistance flatness (ron(flat))	5 Ω				
Turn-on/turn-off time (t _{ON} /t _{OFF})	3.5 ns/2 ns				
Charge injection (Q _C)	2 pC				
Bandwidth (BW)	300 MHz				
OFF isolation (O _{ISO})	-48 dB at 10 MHz				
Crosstalk (X _{TALK})	-48 dB at 10 MHz				
Total harmonic distortion (THD)	0.2%				
Leakage current (I _{COM(OFF)}	±5 μA				
Power-supply current (I ₊)	2.5 μΑ				
Package options	16-pin QFN, uQFN, SOIC, SSOP, TSSOP, or TVSOP				

(1) $V_+ = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$

FUNCTION TABLE

EN	IN	NO TO COM, COM TO NO	NC TO COM, COM TO NC									
L	L	OFF	ON									
L	Н	ON	OFF									
Н	X	OFF	OFF									



Absolute Minimum and Maximum Ratings(1) (2)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V ₊	Supply voltage range (3)		-0.5	4.6	V
V_{NC} V_{NO} V_{COM}	Analog voltage range ⁽³⁾ (4)		-0.5	4.6	V
I _K	Analog port diode current	V _{NC} , V _{NO} , V _{COM} < 0	-50		mA
I _{NC} I _{NO} I _{COM}	On-state switch current	V_{NC} , V_{NO} , $V_{COM} = 0$ to 7 V	-64	64	mA
V_{I}	Digital input voltage range (3) (4)		-0.5	4.6	V
I _{IK}	Digital input clamp current	V _I < 0	-50		mA
I ₊	Continuous current through V ₊		-100	100	mA
I_{GND}	Continuous current through GND		-100	100	mA
		D package		73	
		DBQ package		90	
0	Dooks so thermal impedence (5)	DGV package		120	°C // //
θ_{JA}	Package thermal impedance (5)	PW package		108 °C/W	
		RGY package		51	
		RSV package		184	
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(5) The package thermal impedance is calculated in accordance with JESD 51-7.

⁽²⁾ The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum

⁽³⁾ All voltages are with respect to ground, unless otherwise specified.

⁽⁴⁾ The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



Electrical Characteristics for 3.3-V Supply⁽¹⁾

 $V_{+} = 3 \text{ V to } 3.6 \text{ V}, T_{A} = -40^{\circ}\text{C} \text{ to } 85^{\circ}\text{C} \text{ (unless otherwise noted)}$

PARAMETER	SYMBOL	TEST CON	NDITIONS	TA	V ₊	MIN	TYP	MAX	UNIT
Analog Switch		•							
Analog signal range	V_{COM}, V_{NO}, V_{NC}					0		V ₊	V
ON-state resistance	r _{on}	$0 \le (V_{NC} \text{ or } V_{NO}) \le V_+,$ $I_{COM} = -32 \text{ mA},$	Switch ON, See Figure 13	25°C Full	3 V		7	10 12	Ω
ON-state resistance	$\Delta r_{ m on}$	V_{NC} or $V_{NO} = 2.1 V$,	Switch ON,	25°C	3 V		0.3	0.8	Ω
match between channels	Zi on	$I_{COM} = -32 \text{ mA},$	See Figure 13	Full	- V			1	32
ON-state resistance	r(g-0	$0 \le (V_{NC} \text{ or } V_{NO}) \le V_+,$	Switch ON,	25°C	3 V		5	7	Ω
flatness	r _{on(flat)}	$I_{COM} = -32 \text{ mA},$	See Figure 13	Full	J V			8	
		V_{NC} or $V_{NO} = 1 V$, $V_{COM} = 3 V$,		25°C		-0.1	0.05	0.1	
NC, NO	I _{NC(OFF)} ,	or V _{NC} or V _{NO} = 3 V, V _{COM} = 1 V,	Switch OFF, See Figure 14	Full	3.6 V	-0.2		0.2	^
OFF leakage current	I _{NO(OFF)}	V_{NC} or $V_{NO} = 0$ to 3.6 V,		25°C		-2	0.05	2	μΑ
		$V_{\text{COM}} = 3.6 \text{ V to 0},$ or $V_{\text{NC}} \text{ or } V_{\text{NO}} = 3.6 \text{ V to 0},$ $V_{\text{COM}} = 0 \text{ to } 3.6 \text{ V},$ Switch OFF, See Figure 14	Full	0 V	-10		10		
		$V_{COM} = 1 V$		25°C		-0.1	0.05	0.1	
COM	I	V_{NC} or $V_{NO} = 3 \text{ V}$, or $V_{COM} = 3 \text{ V}$, V_{NC} or $V_{NO} = 3 \text{ V}$,	Switch OFF, See Figure 14	Full	3.6 V	-0.2		0.2	μΑ
OFF leakage current	ICOM(OFF)	$V_{COM} = 0 \text{ to } 3.6 \text{ V},$		25°C		-2	0.05	2	
		l Or	Switch OFF, See Figure 14	Full	0 V	-10		10	
NO NO		V_{NC} or $V_{NO} = 1 V$,		25°C		-0.1	0.05	0.1	
NC, NO ON leakage current	I _{NC(ON)} , I _{NO(ON)}	$V_{COM} = Open,$ or V_{NC} or $V_{NO} = 3 V,$ $V_{COM} = Open,$	Switch ON, See Figure 15	Full	3.6 V	-0.2		0.2	μА
0014		$V_{COM} = 1 V$		25°C		-0.1	0.05	0.1	
COM ON leakage current	$I_{COM(ON)} \begin{tabular}{ll} V_{NC} or $V_{NO} = Open, \\ or \\ $V_{COM} = 3$ V, \\ V_{NC} or $V_{NO} = Open, \\ \end{tabular} \begin{tabular}{ll} $Switch ON, \\ See Figure 15 \\ \end{tabular}$		Full	3.6 V	-0.2		0.2	μА	
Digital Control	Inputs (IN, EN)	(2)							
Input logic high	V _{IH}			Full		2		V ₊	V
Input logic low	V _{IL}			Full		0		0.8	V
Input leakage current	I _{IH} , I _{IL}	$V_I = V_+ \text{ or } 0$		25°C Full	3.6 V	-1 -1	0.05	1	μΑ
				Full	I	-1		1	

⁽¹⁾ The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

⁽²⁾ All unused digital inputs of the device must be held at V₁ or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



Electrical Characteristics for 3.3-V Supply (1) (continued)

 $V_{+} = 3 \text{ V}$ to 3.6 V, $T_{A} = -40^{\circ}\text{C}$ to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CON	IDITIONS	T _A	V ₊	MIN	TYP	MAX	UNIT
Dynamic									
		V - 2 V	$C_1 = 35 \text{ pF},$	25°C	3.3 V	2.5	3.5	8	
Turn-on time	t _{ON}	$V_{COM} = 2 V$, $R_L = 300 \Omega$,	See Figure 17	Full	3 V to 3.6 V	2.5		9	ns
		V _{COM} = 2 V,	$C_{L} = 35 \text{ pF},$	25°C	3.3 V	0.5	2	6.5	
Turn-off time	t _{OFF}	$R_L = 300 \Omega$	See Figure 17	Full	3 V to 3.6 V	0.5		7	ns
Charge injection	Q_{C}	$V_{GEN} = 0,$ $R_{GEN} = 0,$	C _L = 0.1 nF, See Figure 22	25°C	3.3 V		2		рС
NC, NO OFF capacitance	$\begin{matrix} C_{NC(OFF)}, \\ C_{NO(OFF)} \end{matrix}$	V_{NC} or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 16	25°C	3.3 V		4.5		pF
COM OFF capacitance	C _{COM(OFF)}	V _{COM} = V ₊ or GND, Switch OFF,	See Figure 16	25°C	3.3 V		9		pF
NC, NO ON capacitance	C _{NC(ON)} , C _{NO(ON)}	V_{NC} or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 16	25°C	3.3 V		16		pF
COM ON capacitance	C _{COM(ON)}	V _{COM} = V ₊ or GND, Switch ON,	See Figure 16	25°C	3.3 V		16		pF
Digital input capacitance	Cı	$V_I = V_+ \text{ or GND},$	See Figure 16	25°C	3.3 V		3		pF
Bandwidth	BW	$R_L = 50 \Omega$, Switch ON,	See Figure 18	25°C	3.3 V		300		MHz
OFF isolation	O _{ISO}	$R_L = 50 \Omega$, f = 10 MHz,	Switch OFF, See Figure 19	25°C	3.3 V		-48		dB
Crosstalk	X_{TALK}	$R_L = 50 \Omega$, f = 10 MHz,	Switch ON, See Figure 20	25°C	3.3 V		-48		dB
Crosstalk adjacent	X _{TALK(ADJ)}	$R_L = 50 \Omega$, f = 10 MHz,	Switch ON, See Figure 21	25°C	3.3 V		-81		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 20 Hz to 20 kHz, See Figure 23	25°C	3.3 V		0.21		%
Supply		•							
Positive supply current	I ₊	$V_I = V_+ \text{ or GND},$	Switch ON or OFF	25°C Full	3.6 V		2.5	7 10	μА

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Electrical Characteristics for 2.5-V Supply⁽¹⁾

 $V_{+} = 2.3 \text{ V to } 2.7 \text{ V}, T_{A} = -40^{\circ}\text{C} \text{ to } 85^{\circ}\text{C} \text{ (unless otherwise noted)}$

PARAMETER	SYMBOL	TEST COM	IDITIONS	TA	V ₊	MIN	TYP	MAX	UNIT
Analog Switch									
Analog signal range	V_{COM}, V_{NC}, V_{NO}					0		V ₊	V
ON-state resistance	r _{on}	$0 \le (V_{NC} \text{ or } V_{NO}) \le V_+,$ $I_{COM} = -24 \text{ mA},$	Switch ON, See Figure 13	25°C Full	2.3 V		12	20 22	Ω
ON-state resistance	$\Delta r_{ m on}$	V_{NC} or $V_{NO} = 1.6 \text{ V}$,	Switch ON,	25°C	2.3 V		0.3	1	Ω
match between channels		$I_{COM} = -24 \text{ mA},$	See Figure 13	Full				2	
ON-state resistance	r _{on(flat)}	$0 \le (V_{NC} \text{ or } V_{NO}) \le V_+,$	Switch ON,	25°C	2.3 V		14	18	Ω
flatness	($I_{COM} = -24 \text{ mA},$	See Figure 13	Full				20	
		V_{NC} or $V_{NO} = 0.5 \text{ V}$, $V_{COM} = 2.2 \text{ V}$,	0 11 055	25°C		-0.1	0.05	0.1	
NC, NO OFF leakage	I _{NC(OFF)} ,	or V_{NC} or $V_{NO} = 2.2 \text{ V}$, $V_{COM} = 0.5 \text{ V}$,	Switch OFF, See Figure 14	Full	2.7 V	-0.2		0.2	٨
current	INO(OFF)	V_{NC} or $V_{NO} = 0$ to 3.6 V,	Switch OFF, See Figure 14	25°C		-2	0.05	2	- μΑ
		Or		Full	0 V	-10		10	
		$V_{COM} = 0.5 \text{ V},$		25°C		-0.1	0.05	0.1	
COM	l	V_{NC} or $V_{NO} = 2.2 \text{ V}$, or $V_{COM} = 2.2 \text{ V}$, V_{NC} or $V_{NO} = 0.5 \text{ V}$,	Switch OFF, See Figure 14	Full	2.7 V	-0.2		0.2	1
OFF leakage current	I _{COM(OFF)}	$V_{COM} = 0 \text{ to } 3.6 \text{ V},$		25°C		-2	0.05	2	μΑ
		$\begin{split} &V_{NC} \text{ or } V_{NO} = 3.6 \text{ V to 0,} \\ &\text{or} \\ &V_{COM} = 3.6 \text{ V to 0,} \\ &V_{NC} \text{ or } V_{NO} = 0 \text{ to } 3.6 \text{ V,} \end{split}$	Switch OFF, See Figure 14	Full	0 V	-10		10	
NC NO		V_{NC} or $V_{NO} = 0.5 \text{ V}$,		25°C		-0.1	0.05	0.1	
NC, NO ON leakage current	I _{NC(ON)} , I _{NO(ON)}	V_{COM} = Open, or V_{NC} or V_{NO} = 2.2 V, V_{COM} = Open,	Switch ON, See Figure 15	Full	2.7 V	-0.2		0.2	μΑ
		V _{COM} = 0.5 V,		25°C		-0.1	0.05	0.1	
COM ON leakage current	I _{COM(ON)}	V_{NC} or V_{NO} = Open, or V_{COM} = 2.2 V, V_{NC} or V_{NO} = Open,	Switch ON, See Figure 15	Full	2.7 V	-0.2		0.2	μΑ
Digital Control	Inputs (IN, EN)	2)							
Input logic high	V_{IH}			Full		1.7		V ₊	V
Input logic low	V_{IL}			Full		0		0.7	V
Input leakage current	I _{IH} , I _{IL}	$V_I = V_+ \text{ or } 0$		25°C	2.7 V	-0.1	0.05	0.1	μΑ
Carron				Full		-1		1	

⁽¹⁾ The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

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⁽²⁾ All unused digital inputs of the device must be held at V₁ or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



Electrical Characteristics for 2.5-V Supply (1) (continued)

 $V_{+} = 2.3 \text{ V}$ to 2.7 V, $T_{A} = -40^{\circ}\text{C}$ to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CON	IDITIONS	T _A	V ₊	MIN	TYP	MAX	UNIT
Dynamic									
		\/ -15\/	C = 25 pE	25°C	2.5 V	2.5	5	9.5	
Turn-on time	t _{ON}	$V_{COM} = 1.5 \text{ V},$ $R_L = 300 \Omega,$	C _L = 35 pF, See Figure 17	Full	2.3 V to 2.7 V	2.5		10.5	ns
		\/ 4.5.\/	C 25 nF	25°C	2.5 V	0.5	3	7.5	
Turn-off time	t _{OFF}	$V_{COM} = 1.5 \text{ V},$ $R_L = 300 \Omega,$	C _L = 35 pF, See Figure 17	Full	2.3 V to 2.7 V	0.5		9	ns
Charge injection	$Q_{\mathbb{C}}$	V _{GEN} = 0, R _{GEN} = 0,	C _L = 0.1 nF, See Figure 22	25°C	2.5 V		1		рС
NC, NO OFF capacitance	$\begin{array}{c} C_{NC(OFF)}, \\ C_{NO(OFF)} \end{array}$	V_{NC} or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 16	25°C	2.5 V		3		pF
COM OFF capacitance	C _{COM(OFF)}	V _{COM} = V ₊ or GND, Switch OFF,	See Figure 16	25°C	2.5 V		9		pF
NC, NO ON capacitance	C _{NC(ON)} , C _{NO(ON)}	V _{NC} or V _{NO} = V ₊ or GND, Switch ON,	See Figure 16	25°C	2.5 V		16		pF
COM ON capacitance	C _{COM(ON)}	$V_{COM} = V_{+}$ or GND, Switch ON,	See Figure 16	25°C	2.5 V		16		pF
Digital input capacitance	Cı	$V_I = V_+ \text{ or GND},$	See Figure 16	25°C	2.5 V		3		pF
Bandwidth	BW	$R_L = 50 \Omega$, Switch ON,	See Figure 18	25°C	2.5 V		300		MHz
OFF isolation	O _{ISO}	$R_L = 50 \Omega$, f = 10 MHz,	Switch OFF, See Figure 19	25°C	2.5 V		-48		dB
Crosstalk	X _{TALK}	$R_L = 50 \Omega$, f = 10 MHz,	Switch ON, See Figure 20	25°C	2.5 V		-48		dB
Crosstalk adjacent	X _{TALK(ADJ)}	$R_L = 50 \Omega$, f = 10 MHz,	Switch ON, See Figure 21	25°C	3.3 V		-81		dB
Total harmonic distortion	THD	$R_L = 600 \ \Omega,$ $C_L = 50 \ pF,$	f = 20 Hz to 20 kHz, See Figure 23	25°C	2.5 V		0.33		%
Supply		·						,	
Positive supply current	I ₊	$V_I = V_+ \text{ or GND},$	Switch ON or OFF	25°C Full	2.7 V		2.5	7 10	μА



TYPICAL PERFORMANCE

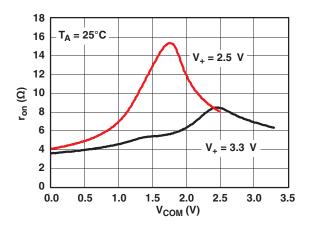


Figure 1. ron vs V_{COM}

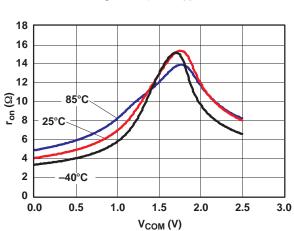


Figure 3. r_{on} vs V_{COM} ($V_{+} = 2.5 \text{ V}$)

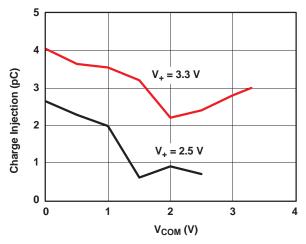


Figure 5. Charge Injection (Q_C) vs V_{COM}

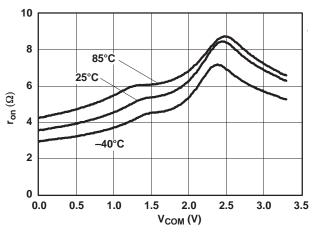


Figure 2. r_{on} vs V_{COM} ($V_{+} = 2.5 \text{ V}$)

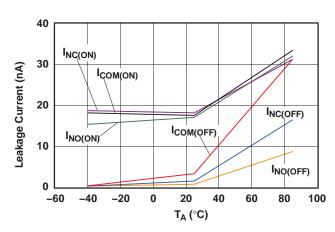


Figure 4. Leakage Current vs Temperature (V₊ = 3.6 V)

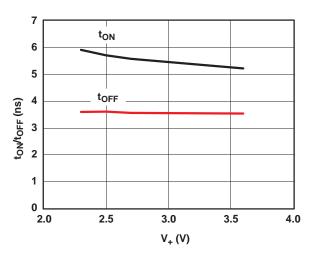


Figure 6. t_{ON} and t_{OFF} vs Supply Voltage



TYPICAL PERFORMANCE (continued)

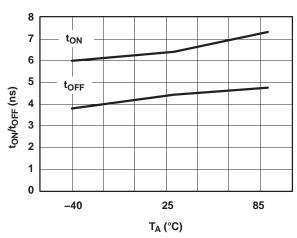


Figure 7. t_{ON} and t_{OFF} vs Temperature (V₊ = 3.3 V)

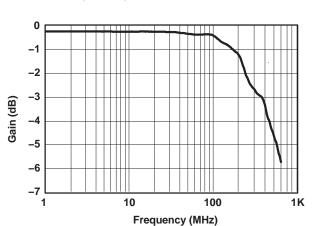


Figure 9. Gain vs Frequency Bandwidth ($V_{+} = 3.3 \text{ V}$)

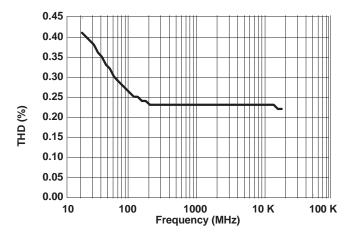


Figure 11. Total Harmonic Distortion vs Frequency

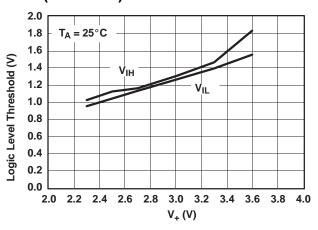


Figure 8. Logic-Level Threshold vs V₊

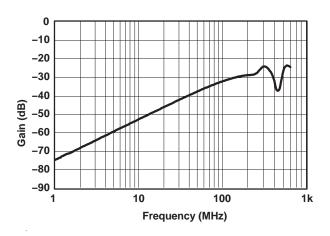


Figure 10. OFF Isolation and Crosstalk vs Frequency (V $_{\scriptscriptstyle +}$ = 3.3 V)

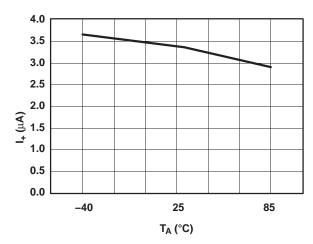


Figure 12. Power-Supply Current vs Temperature ($V_{\star} = 3.3 \text{ V}$)



PIN DESCRIPTION

PIN	NAME	DESCRIPTION
NO.	INAIVIE	DESCRIPTION
1	IN	Digital control pin to select between NC and NO
2	NC1	Normally closed
3	NO1	Normally open
4	COM1	Common
5	NC2	Normally closed
6	NO2	Normally open
7	COM2	Common
8	GND	Digital ground
9	COM3	Common
10	NO3	Normally open
11	NC3	Normally closed
12	COM4	Common
13	NO4	Normally open
14	NC4	Normally closed
15	EN	Chip enable (active low)
16	V ₊	Power supply



PARAMETER DESCRIPTION

SYMBOL	DESCRIPTION
V _{COM}	Voltage at COM
V _{NC}	Voltage at NC
V _{NO}	Voltage at NO
r _{on}	Resistance between COM and NC or NO ports when the channel is ON
Δr_{on}	Difference of ron between channels in a specific device
r _{on(flat)}	Difference between the maximum and minimum value of ron in a channel over the specified range of conditions
I _{NC(OFF)}	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the OFF state
I _{NC(ON)}	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the ON state and the output (COM) open
I _{NO(OFF)}	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the OFF state
I _{NO(ON)}	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the ON state and the output (COM) open
I _{COM(OFF)}	Leakage current measured at the COM port, with the corresponding channel (COM to NC or NO) in the OFF state
I _{COM(ON)}	Leakage current measured at the COM port, with the corresponding channel (COM to NC or NO) in the ON state and the output (NC or NO) open
V_{IH}	Minimum input voltage for logic high for the control input (IN, EN)
V_{IL}	Maximum input voltage for logic low for the control input (IN, EN)
VI	Voltage at the control input (IN, $\overline{\text{EN}}$)
I _{IH} , I _{IL}	Leakage current measured at the control input (IN, EN)
t _{ON}	Turn-on time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output NC or NO) signal when the switch is turning ON.
t _{OFF}	Turn-off time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output (NC or NO) signal when the switch is turning OFF.
Q _C	Charge injection is a measurement of unwanted signal coupling from the control (IN) input to the analog (NC or NO) output. This is measured in coulomb (C) and measured by the total charge induced due to switching of the control input. Charge injection, $Q_C = C_L \times \Delta V_{COM}$, C_L is the load capacitance and ΔV_{COM} is the change in analog output voltage.
C _{NC(OFF)}	Capacitance at the NC port when the corresponding channel (NC to COM) is OFF
C _{NC(ON)}	Capacitance at the NC port when the corresponding channel (NC to COM) is ON
C _{NO(OFF)}	Capacitance at the NC port when the corresponding channel (NO to COM) is OFF
C _{NO(ON)}	Capacitance at the NC port when the corresponding channel (NO to COM) is ON
C _{COM(OFF)}	Capacitance at the COM port when the corresponding channel (COM to NC) is OFF
C _{COM(ON)}	Capacitance at the COM port when the corresponding channel (COM to NC) is ON
C _I	Capacitance of control input (IN, EN)
O _{ISO}	OFF isolation of the switch is a measurement of OFF-state switch impedance. This is measured in dB in a specific frequency, with the corresponding channel (NC to COM) in the OFF state.
X _{TALK}	Crosstalk is a measurement of unwanted signal coupling from an ON channel to an OFF channel (NC1 to NO1). Adjacent crosstalk is a measure of unwanted signal coupling from an ON channel to an adjacent ON channel (NC1 to NC2) . This is measured in a specific frequency and in dB.
BW	Bandwidth of the switch. This is the frequency in which the gain of an ON channel is -3 dB below the DC gain.
THD	Total harmonic distortion describes the signal distortion caused by the analog switch. This is defined as the ratio of root mean square (RMS) value of the second, third, and higher harmonic to the absolute magnitude of the fundamental harmonic.
I ₊	Static power-supply current with the control (IN) pin at V ₊ or GND

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PARAMETER MEASUREMENT INFORMATION

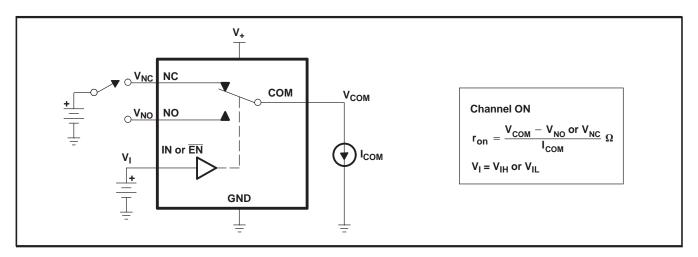


Figure 13. ON-State Resistance (ron)

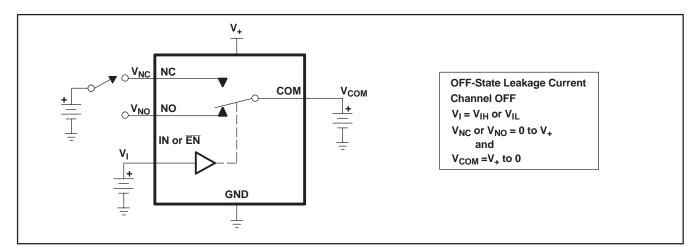


Figure 14. OFF-State Leakage Current ($I_{COM(OFF)}$, $I_{NC(OFF)}$, $I_{NO(OFF)}$)

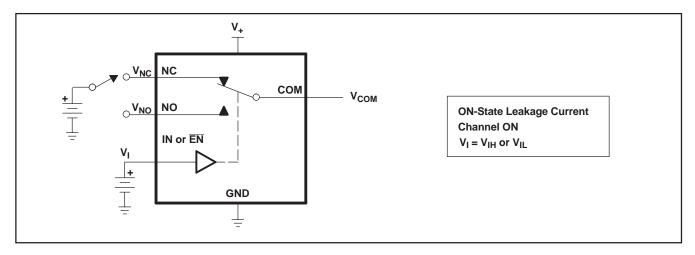


Figure 15. ON-State Leakage Current (I_{COM(ON)}, I_{NC(ON)})



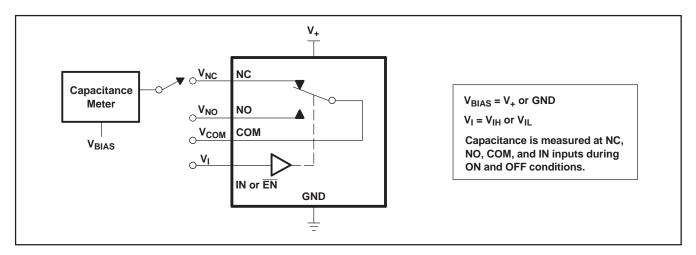
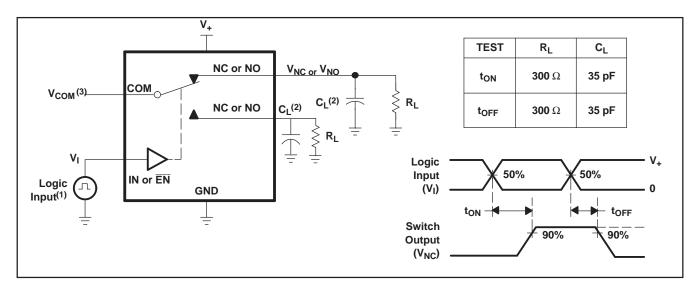


Figure 16. Capacitance (C_I, $C_{COM(OFF)}$, $C_{COM(ON)}$, $C_{NC(OFF)}$, $C_{NC(ON)}$)



- A. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_r < 5 \text{ ns}$, $t_f < 5 \text{ ns}$.
- B. C_L includes probe and jig capacitance.
- C. See Electrical Characteristics for V_{COM}.

Figure 17. Turn-On (t_{ON}) and Turn-Off Time (t_{OFF})

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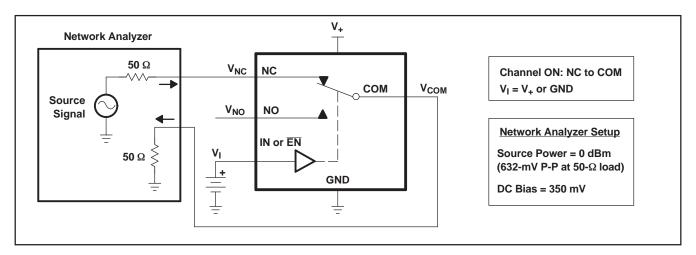


Figure 18. Bandwidth (BW)

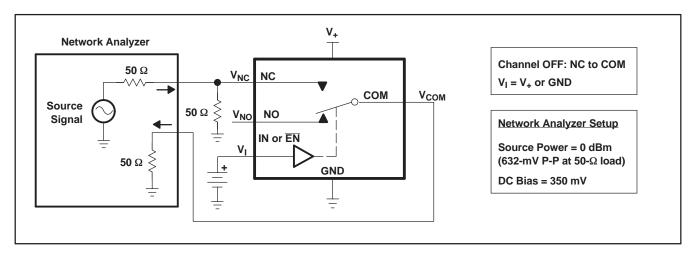


Figure 19. OFF Isolation (O_{ISO})

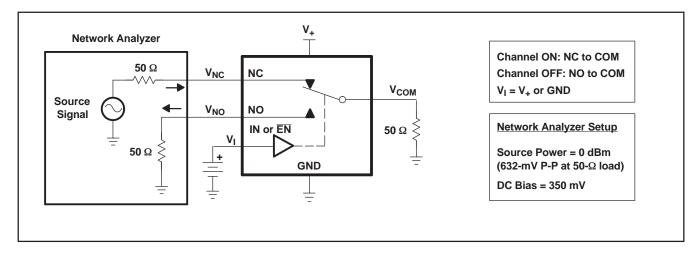


Figure 20. Crosstalk (X_{TALK})



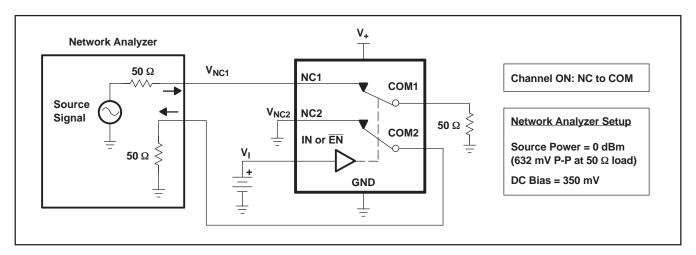
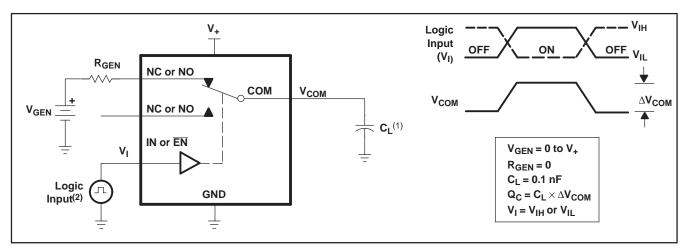


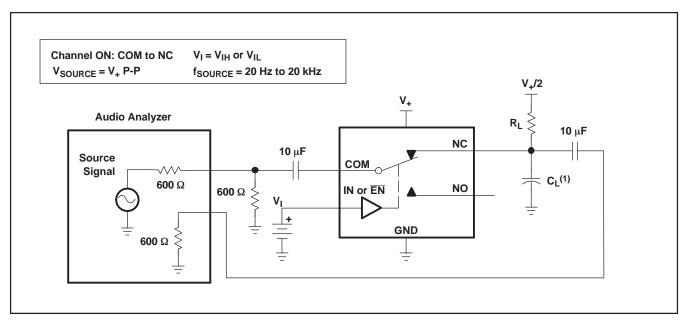
Figure 21. Crosstalk Adjacent



- A. C_L includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f < 5 \text{ ns}$, $t_f < 5 \text{ ns}$.

Figure 22. Charge Injection (Q_C)





A. C_L includes probe and jig capacitance.

Figure 23. Total Harmonic Distortion (THD)



10-Jun-2010

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
TS3A5018D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributor or Sales Office
TS3A5018DBQR	ACTIVE	SSOP/QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	Request Free Sample
TS3A5018DBQRE4	ACTIVE	SSOP/QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	Request Free Sample
TS3A5018DBQRG4	ACTIVE	SSOP/QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	Request Free Sample
TS3A5018DE4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributo or Sales Office
TS3A5018DG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributo or Sales Office
TS3A5018DGVR	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample
TS3A5018DGVRE4	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample
TS3A5018DGVRG4	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample
TS3A5018DR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample
TS3A5018DRE4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample
TS3A5018DRG4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample
TS3A5018PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distribute or Sales Office
TS3A5018PWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distribute or Sales Office
TS3A5018PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Contact TI Distributo or Sales Office
TS3A5018PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample
TS3A5018PWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Sample



PACKAGE OPTION ADDENDUM

10-Jun-2010

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
TS3A5018PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples
TS3A5018RGYR	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	Request Free Samples
TS3A5018RGYRG4	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	Request Free Samples
TS3A5018RSVR	ACTIVE	UQFN	RSV	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Request Free Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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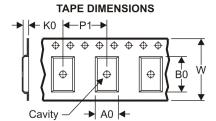
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PACKAGE MATERIALS INFORMATION

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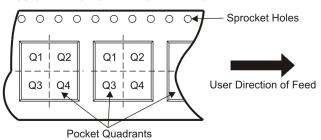
TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

All difficultions are nomina	l											
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3A5018DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
TS3A5018DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TS3A5018PWR	TSSOP	PW	16	2000	330.0	12.4	7.0	5.6	1.6	8.0	12.0	Q1
TS3A5018RGYR	VQFN	RGY	16	3000	180.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1

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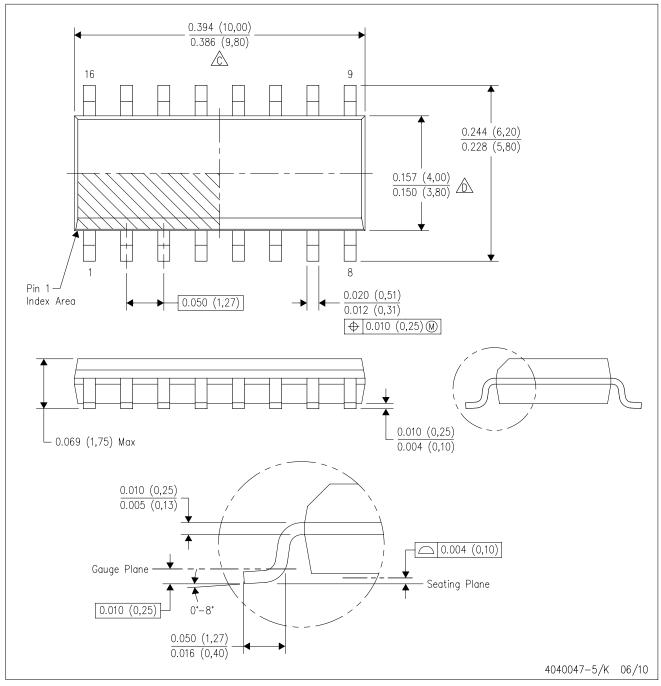


*All dimensions are nominal

7 III dillionorio di c ricinima								
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TS3A5018DGVR	TVSOP	DGV	16	2000	346.0	346.0	29.0	
TS3A5018DR	SOIC	D	16	2500	333.2	345.9	28.6	
TS3A5018PWR	TSSOP	PW	16	2000	346.0	346.0	29.0	
TS3A5018RGYR	VQFN	RGY	16	3000	190.5	212.7	31.8	

D (R-PDS0-G16)

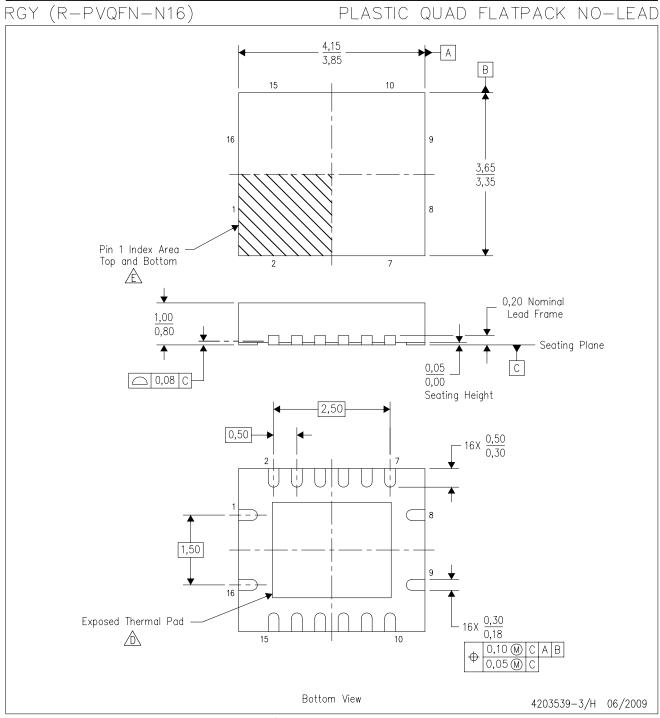
PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AC.

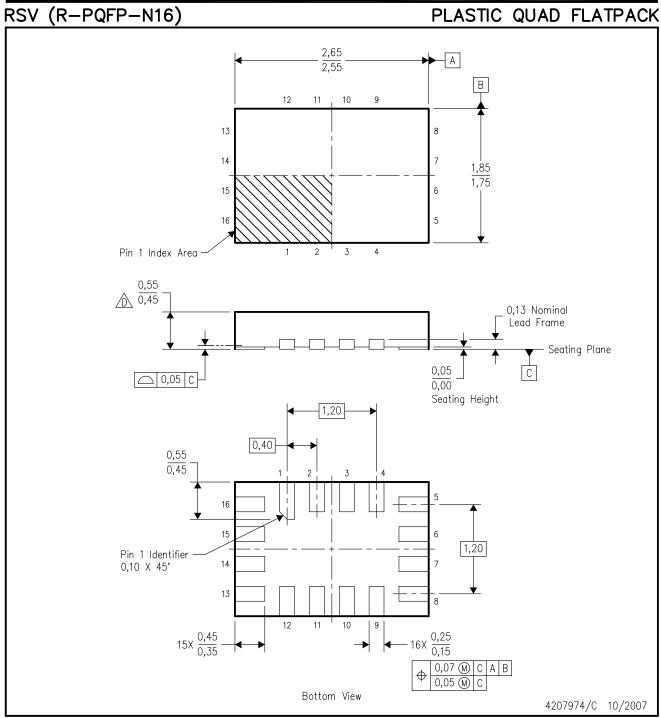




NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- F. Package complies to JEDEC MO-241 variation BB.





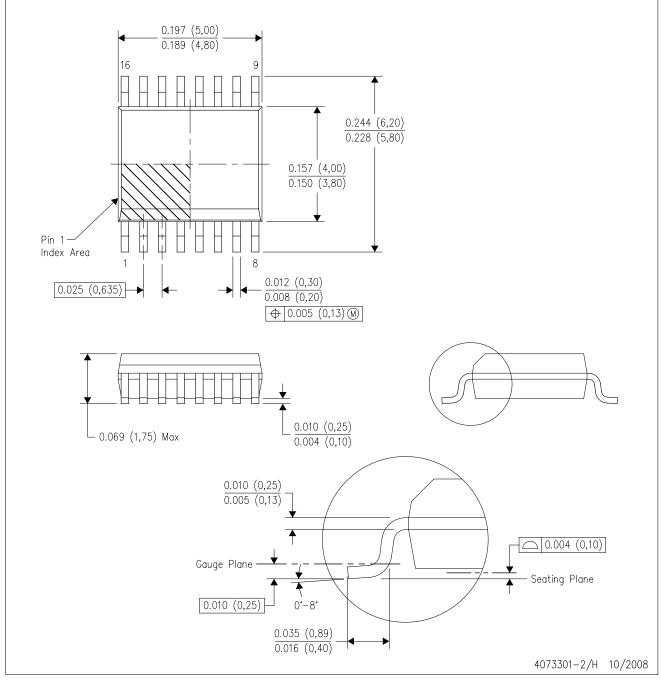
NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- This package complies to JEDEC MO-288 variation UFHE, except minimum package thickness.



DBQ (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



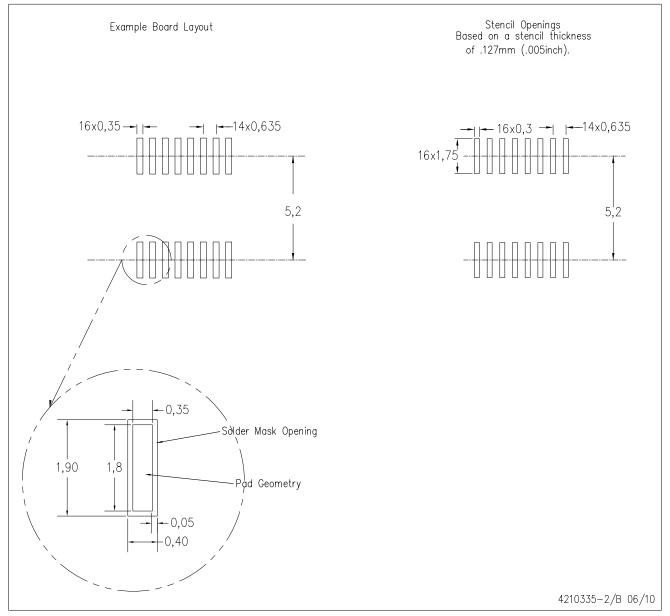
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AB.



DBQ (R-PDSO-G16)

PLASTIC SMALL OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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